

OIML Certificate of Conformity

OIML Member State The Netherlands Number R60/2000-NL1-14.08 Project number 13200001 Page 1 of 3

Issuing authority NMi Certin B.V. Person responsible: C. Oosterman Applicant and Beijing True-Tec Co., Ltd. Manufacturer 4/F, Bldg. 2, No. 8, Hong Da Bei Lu, RDA Beijing China Identification of the A bending beam load cell, with strain gauges. certified type Type PA08R, PA08G and PA08 Characteristics See next page This Certificate attests the conformity of the above identified Type (represented by the sample(s) identified in the OIML Test Report) with the requirements of the following Recommendation of the International Organization of Legal Metrology (OIML): OIML R60 - Edition 2000 (E) for accuracy class C This Certificate relates only to the metrological and technical characteristics of the type of measuring instrument covered by the relevant OIML International Recommendation above-identified. This Certificate does not bestow any form of legal international approval. Important note: Apart from the mention of the Certificate's reference number and the name of the OIML Member State in which the Certificate was issued, partial quotation of the Certificate and of the associated OIML Test Report(s) is not permitted, although either may be reproduced in full. NMi Certin B.V., OIML Issuing Authority Issuina 2 April 2014 Oosterman Head Certification Board NMi Certin B V This document is issued under the Parties concerned can Hugo de Grootplein 1 provision that no liability is lodge objection against 3314 EG Dordrecht accepted and that the applicant this decision, within six the Netherlands shall indemnify third-party liability. weeks after the date of T+31 78 6332332 submission, to the The notification of NMi Certin B.V. general manager of NMi certin@nmi.nl as Issuing Authority can be verified www.nmi.nl (see www.nmi.nl). at www.oiml.org



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Characteristics of the load cell: + + +			+ $+$ $+$ $+$	+ $+$ $+$ $+$									
Type + + + + + + + + + + + +	+ + + PA	08R + + +	+ PA08G +	+ PA08L +									
Maximum capacity (E _{max})	10 kg up to 50 kg	50 kg up to and including 100 kg	50 kg up to and including 250 kg	50 kg up to and including 300 kg									
Maximum number of load cell intervals (n)	+ 6000 +	+ + 6000 +	+ +6000+ +	+ 4000 +									
Ratio of minimum LC Verification interval $Y = E_{max} / v_{min}$	15000	7500	16000	15000									
Ratio of minimum dead load output return Z = E _{max} / (2 * DR)	11000	20000	77000	4994									
Minimum dead load	+ + + +	+ + + • 0	kg	+ + + +									
Accuracy Class + + + + + + + + +	+ $+$ $+$ $+$	+ + + + +	C+ + + + +	+ + + +									
Rated Output	2,0 mV/V ± 0,2 mV/V												
Input impedance	406 Ω ± 15 Ω												
Temperature range + + + + + + +	+ + + + + + + + + + + + + + + + + + +												
Fraction p _{LC}	+ + + +	+ + + + to),7 + + + +	+ + + +									
Humidity Class	* * * *	(Эң	* * * *									
Safe overload	+ + + +	+ + + 150 %	of E _{max} + + +	+ + + +									
Output impedance	+ + + +	+ + + 350 Ω	$\Omega \pm 3 \Omega$ + + +	+ + + +									
Recommended excitation	+ + + +	10 V A	AC / DC	* * * *									
Excitation maximum	+ + + +	+ + + 15 V A	AC / DC	+ + + +									
Transducer material	+ + + +	+ + + Alum	ninium + + +	+ $+$ $+$ $+$									
Atmospheric protection	+ + + +	Silicon	rubber	+ + + +									



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The above identified Type (represented by the sample(s) identified in the OIML Test Report) have been found to comply with the additional national requirements established by the United States of America (NIST Handbook 44 and NCWM Publication 14), included in the MAA																															
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	- 1		R 6	50 E	DoN	۸C-	02	rev	.0,	Ad	diti	ona	al r	equ	uire	eme	ents	s fro	om	the	e Ur	nite	d S	Stat	es.						